Convolutional Neural Networks and Vision Applications

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Deadline for manuscript
submissions:
closed (15 July 2021)

Message from the Guest Editor

Many vision applications can benefit from lightweight and low-power consumption embedded vision systems. Basic low-quality image sensors can be found on systems from cell phones to entertainment game consoles to security systems to high-tech micro unmanned aerial vehicles. For many of these systems, the computational complexity of available vision algorithms prohibits them from being able to perform in real time.

Processing speed is critical for visual inspection automation and mobile visual computing applications. Many powerful and sophisticated vision algorithms generate accurate results but require high computational power and resources and are not suitable for real-time or embedded applications. On the other hand, there are vision algorithms that perform at camera frame rates but with moderately reduced accuracy, which is arguably more applicable for real-time applications.

This special issue is for research related to the design, optimization, and implementation of vision algorithms suitable for real-time embedded vision applications.

Welcome to contribute!

mdpi.com/si/35610

Special Issue

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Message from the Editor-in-Chief

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